

DESCRIPTION

The MP6909 is a low-drop diode emulator IC that, when combined with an external switch, replaces Schottky diodes in high-efficiency flyback converters. The MP6909 regulates the forward drop of an external synchronous rectifier (SR) MOSFET to about 40mV, which switches off once the voltage becomes negative.

The MP6909 can generate its own supply voltage via an internal linear regulator. Programmable ringing detection circuitry prevents the MP6909 from turning on falsely at V_{DS} oscillations during discontinuous conduction mode (DCM) and quasi-resonant operation.

The MP6909 is available in a space-saving TSOT23-6 package.

FEATURES

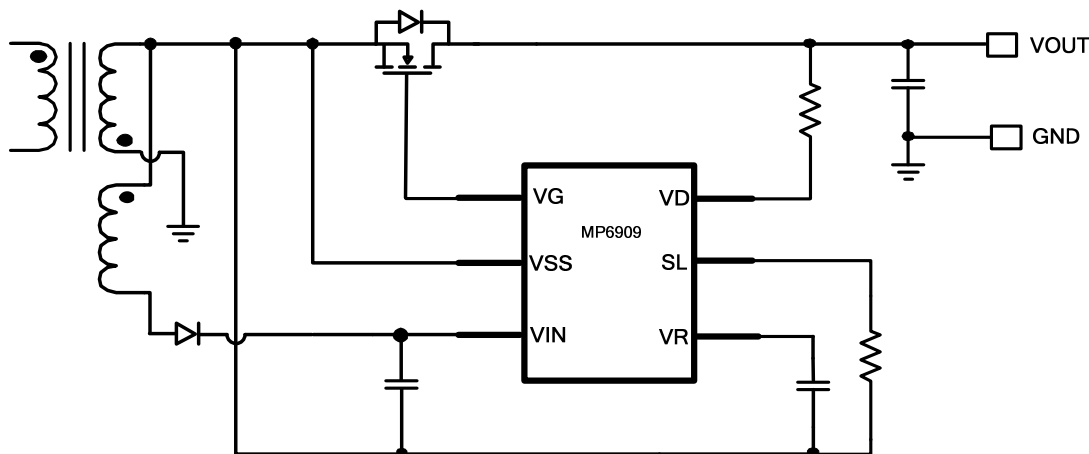
- Supplied Voltage Internally Regulated
- Ringing Detection Prevents False Turn-On during DCM and Quasi-Resonant Operations
- Works with Standard and Logic Level SR MOSFETs
- Compatible with Energy Star
- ~30ns Fast Turn-Off and Turn-On Delay
- ~100 μ A Quiescent Current
- Supports DCM, CCM, and Quasi-Resonant Operations
- Supports both High-Side and Low-Side Rectification
- Available in a TSOT23-6 Package

APPLICATIONS

- USB PD Quick Chargers
- Adaptors
- Flyback Converters

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TYPICAL APPLICATION



ORDERING INFORMATION

Part Number*	Package	Top Marking
MP6909GJ	TSOT23-6	See Below

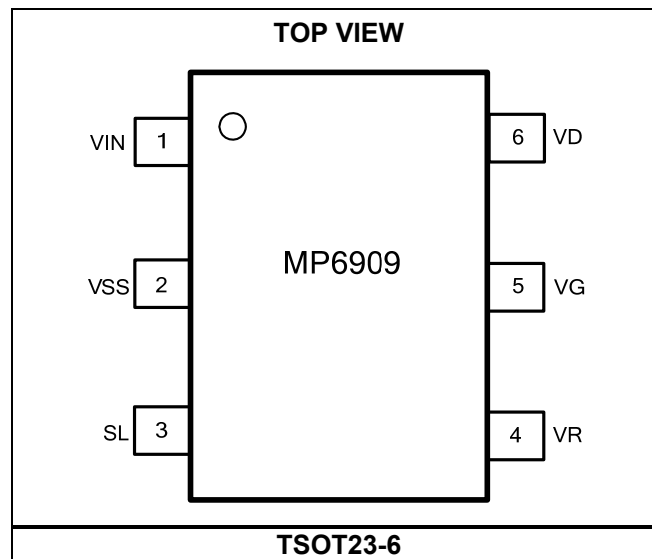
* For Tape & Reel, add suffix -Z (e.g.: MP6909GJ-Z).

TOP MARKING

| BDRY

BDR: Product code of MP6909GJ
Y: Year code

PACKAGE REFERENCE



ABSOLUTE MAXIMUM RATINGS ⁽¹⁾

SL to VSS	-0.3V to +6.5V
VR, VG to VSS	-0.3V to +14V
VD, VIN to VSS	-1V to +180V
Continuous power dissipation (T _A = +25°C) ⁽²⁾	0.56W
Junction temperature	150°C
Lead temperature (solder)	260°C
Storage temperature	-55°C to +150°C

Recommended Operation Conditions ⁽³⁾

VR to VSS	4V to 13V
VD, VIN, to VSS	-1V to +150V
Maximum junction temp. (T _J)	125°C

Thermal Resistance ⁽⁴⁾	θ_{JA}	θ_{JC}
TSOT23-6	220	110

NOTES:

- 1) Exceeding these ratings may damage the device.
- 2) The maximum allowable power dissipation is a function of the maximum junction temperature T_J(MAX), the junction-to-ambient thermal resistance θ_{JA} , and the ambient temperature T_A. The maximum allowable continuous power dissipation at any ambient temperature is calculated by P_D(MAX)=(T_J(MAX)-T_A)/ θ_{JA} . Exceeding the maximum allowable power dissipation produces an excessive die temperature, causing the regulator to go into thermal shutdown. Internal thermal shutdown circuitry protects the device from permanent damage.
- 3) The device is not guaranteed to function outside of its operating conditions.
- 4) Measured on JESD51-7, 4-layer PCB.

ELECTRICAL CHARACTERISTICS

VR = 9V, -40°C ≤ T_J ≤ +125°C, unless otherwise noted.

Parameter	Symbol	Conditions	Min	Typ	Max	Units
Supply Management Section						
VR UVLO rising			3.55	3.75	3.95	V
VR UVLO hysteresis			0.1	0.2	0.3	V
VR maximum charging current	I _{VR}	VR = 7V, VIN = 40V		70		mA
VR regulation voltage		VIN = 12V	8.5	9	9.5	V
Operating current	I _{CC}	VR = 9V, C _{LOAD} = 2.2nF, F _{SW} = 100kHz		2.9	3.5	mA
		VR = 5V, C _{LOAD} = 2.2nF, F _{SW} = 100kHz		1.72	2.1	mA
Quiescent current	I _{q(VR)}	VR = 14V		105	135	μA
Shutdown current	I _{SD(VR)}	VR = UVLO - 0.1V			100	μA
Control Circuitry Section						
Forward regulation voltage (VSS - VD)	V _{fwd}		25	40	55	mV
Turn-on threshold (VDS)			-115	-86	-57	mV
Turn-off threshold (VSS - VD)			-6	3	12	mV
Turn-on delay	T _{Don}	C _{LOAD} = 2.2nF		30	50	ns
Turn-off delay	T _{Doff}	C _{LOAD} = 2.2nF		25	45	ns
Turn-on blanking time	T _{B-ON}	C _{LOAD} = 2.2nF	0.75	1.1	1.45	μs
Turn-off blanking exit threshold	V _{B-OFF}		2		3	V
Turn-off threshold during turn-on blanking			1.3	1.8	2.1	V
Turn-on slew rate detection timer	T _{SLEW}	R _{SLEW} = 400kΩ	51	76	101	ns
Gate Driver Section						
VG (low)	V _{G-L}	I _{LOAD} = 10mA		0.01	0.02	V
VG (high)	V _{G-H}	I _{LOAD} = 0		VR		V
Maximum source current ⁽⁵⁾				0.5		A
Maximum sink current ⁽⁵⁾				3		A
Pull-down impedance		Same as VG (low)		1	2	Ω

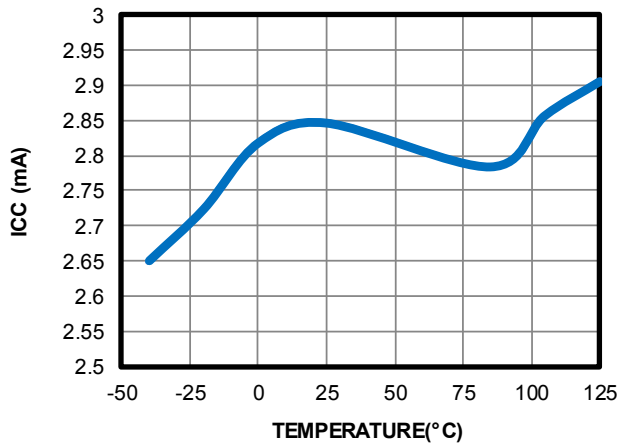
NOTE:

5) Guaranteed by characterization and design.

TYPICAL PERFORMANCE CHARACTERISTICS

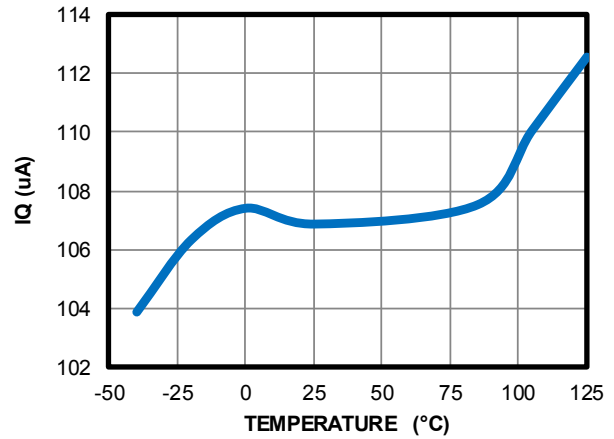
Operating Current vs. Temperature

VR = 9V, C_{LOAD} = 2.2nF, F_{SW} = 100kHz



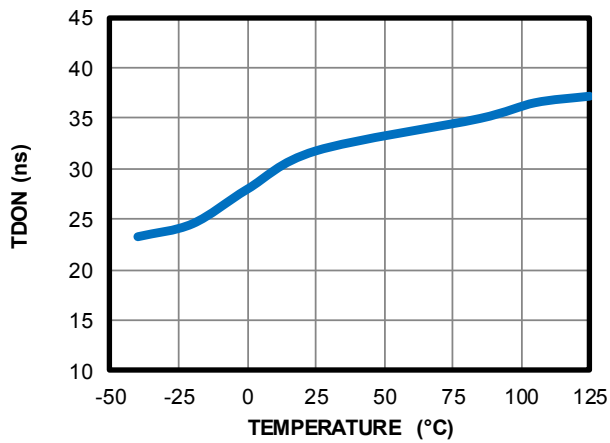
Quiescent Current vs. Temperature

VR = 14V



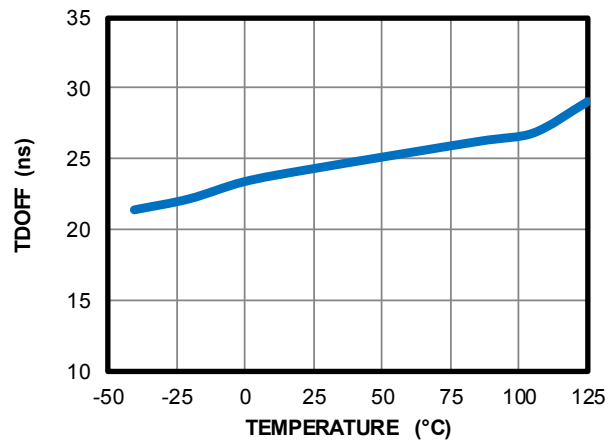
Turn-On Delay vs. Temperature

VR = 9V, C_{LOAD} = 2.2nF

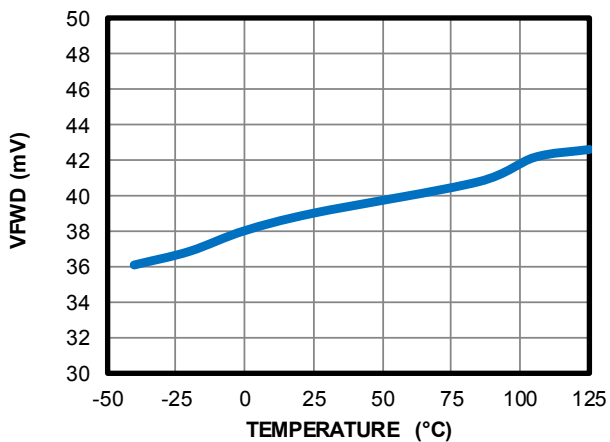


Turn-Off Delay vs. Temperature

VR = 9V, C_{LOAD} = 2.2nF

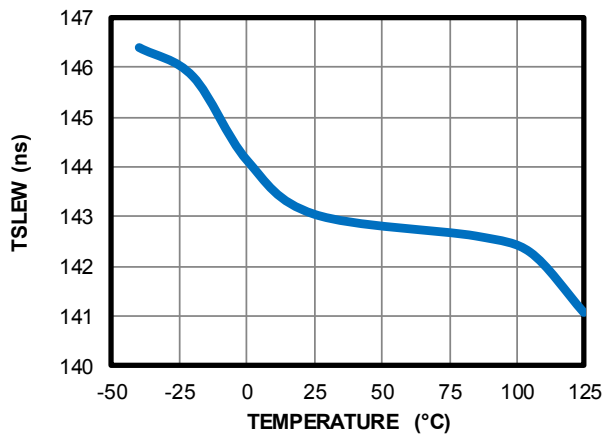


Forward Regulation Voltage (VSS - VD) vs. Temperature



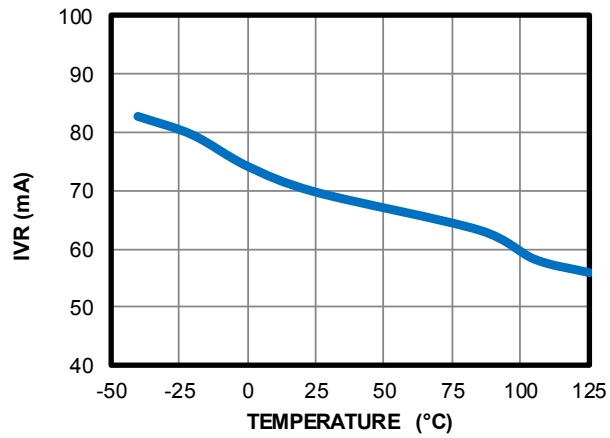
Turn-On Slew Rate Detection Timer vs. Temperature

R_{SLEW} = 400kΩ



TYPICAL PERFORMANCE CHARACTERISTICS *(continued)***VR Maximum Charging Current vs.
Temperature**

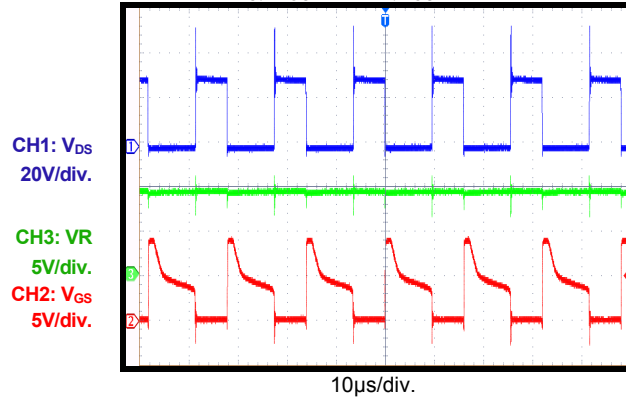
VR = 7V, VIN = 40V



TYPICAL PERFORMANCE CHARACTERISTICS *(continued)*

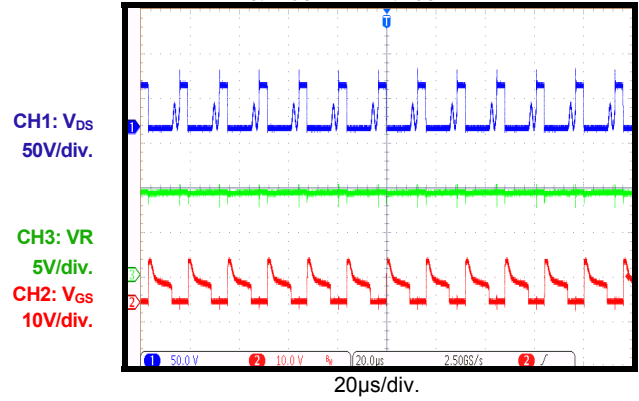
Operation in 36W Flyback Application

$V_{IN} = 110V_{AC}$, $V_{OUT} = 12V$, $I_{OUT} = 3A$



Operation in 36W Flyback Application

$V_{IN} = 220V_{AC}$, $V_{OUT} = 12V$, $I_{OUT} = 3A$



PIN FUNCTIONS

Pin #	Name	Description
1	VIN	Internal linear regulator input.
2	VSS	Ground. VSS is also used as a MOSFET source sense reference for VD.
3	SL	Programming for turn-on signal slew rate detection. SL prevents the SR controller from turning on falsely by ringing below the turn-on threshold at VD in discontinuous conduction mode (DCM) and quasi-resonant mode. Any signal slower than the pre-set slew rate cannot turn on VG.
4	VR	Internal linear regulator output. VR is the supply of the MP6909.
5	VG	Gate drive output.
6	VD	MOSFET drain voltage sense.

BLOCK DIAGRAM

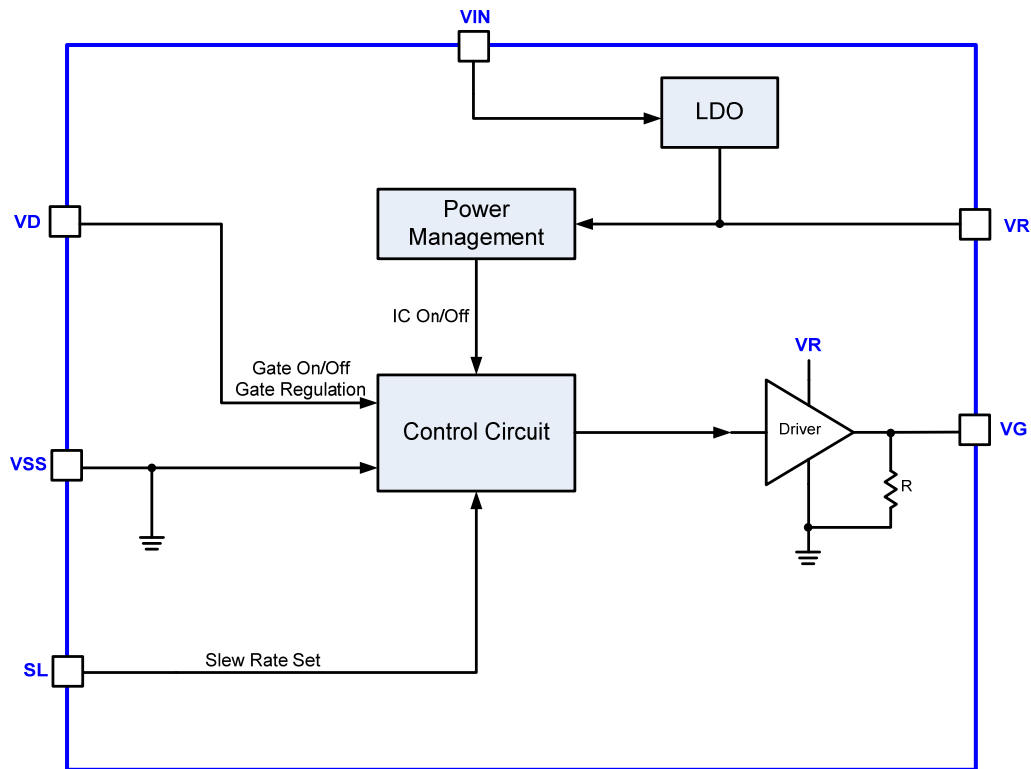


Figure 1: Functional Block Diagram

OPERATION

The MP6909 supports operation in discontinuous conduction mode (DCM), continuous conduction mode (CCM), and quasi-resonant flyback converters. The control circuitry controls the gate in forward mode and turns the gate off when the synchronous rectification (SR) MOSFET current drops to zero.

VR Generation

VIN is the input of the internal linear regulator. VR is the output of the internal linear regulator. The capacitor at VR supplies power for the IC.

When $V_{IN} < 9.3V$, the internal linear regulator regulates VR at $V_{IN}-0.3V$.

When $V_{IN} > 9.3V$, the internal linear regulator regulates VR at 9V.

Start-Up and Under-Voltage Lockout (UVLO)

When VR rises above 3.75V, the MP6909 exits under-voltage lockout (UVLO) and is enabled. The MP6909 enters sleep mode, and V_{GS} is kept low once VR drops below 3.55V.

Turn-On Phase

When V_{DS} drops to $\sim 2V$, a turn-on timer begins to count. This turn-on timer can be programmed by an external resistor on SL. If V_{DS} reaches the -86mV turn-on threshold from 2V within the time (T_{SLEW}) set by the timer, the MOSFET is turned on after a turn-on delay (about 30ns) (see Figure 2). If V_{DS} crosses -86mV after the timer ends, the gate voltage (V_G) remains off. This turn-on timer prevents the MP6909 from turning on falsely due to ringing from DCM and quasi-resonant operations.

T_{SLEW} can be programmed with Equation (1):

$$T_{SLEW} = R_{SLEW} \times \frac{76ns}{400k\Omega} \quad (1)$$

Turn-On Blanking

The control circuitry contains a blanking function. When the MOSFET turns on, the control circuit ensures that the on state lasts for a specific period of time. The turn-on blanking time is $\sim 1.1\mu s$ to prevent an accidental turn-off due to ringing. However, if V_{DS} reaches the turn-off threshold during turn-on blanking within

the turn-on blanking time, V_{GS} is pulled low immediately.

Conduction Phase

When V_{DS} rises above the forward voltage drop ($\sim 40mV$) according to the decrease of the switching current, the MP6909 lowers the gate voltage level to enlarge the on resistance of the synchronous MOSFET.

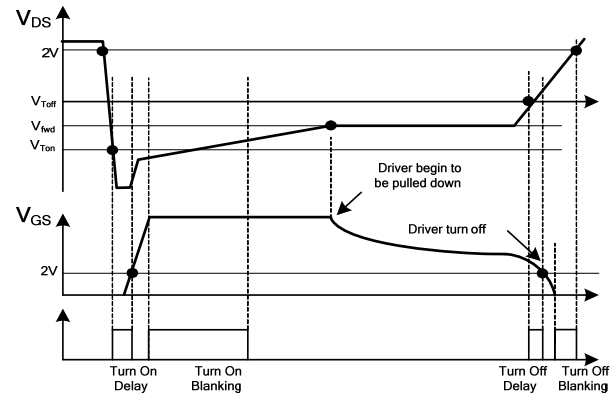


Figure 2: Turn-On/Turn-Off Timing Diagram

With this control scheme, V_{DS} is adjusted to be around $\sim 40mV$ even when the current through the MOSFET is fairly low. This function keeps the driver voltage at a very low level when the synchronous MOSFET is turned off, which boosts the turn-off speed and is especially important for CCM operation.

Turn-Off Phase

When V_{DS} rises to trigger the turn-off threshold ($\sim 3mV$), the gate voltage is pulled to zero after a very short turn-off delay of 25ns (see Figure 2).

Turn-Off Blanking

After the gate driver (V_{GS}) is pulled to zero by V_{DS} reaching the turn-off threshold ($\sim 3mV$), a turn-off blanking time is applied, during which the gate driver signal is latched off. The turn-off blanking is removed when V_{DS} rises above the turn-off blanking exit threshold (2 - 3V) (see Figure 2).

APPLICATION INFORMATION

Slew Rate Detection Function

In DCM operations, the demagnetizing ringing may bring V_{DS} down below 0V. If V_{DS} reaches the turn-on threshold during the ringing, SR controllers without the slew rate detection function may turn on the MOSFET by mistake. Figure 3 shows the waveform of this false turn-on situation. This increases power loss and may also lead to shoot-through if the primary side MOSFET is turned on within the turn-on blanking time.

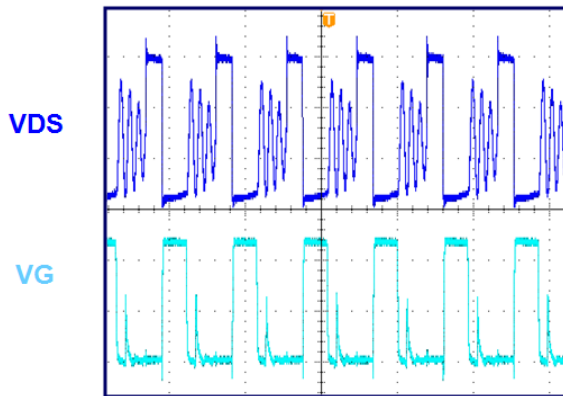


Figure 3: False Turn-On (without Slew Rate Detection)

Considering that the slew rate of the ringing is always much less than when the primary MOSFET is actually turned off, this false turn-on situation can be prevented by the slew rate detection function (see Figure 4). When the slew rate is less than the threshold set by R_{SLEW} , the IC does not turn on the gate even when V_{DS} reaches the turn-on threshold.

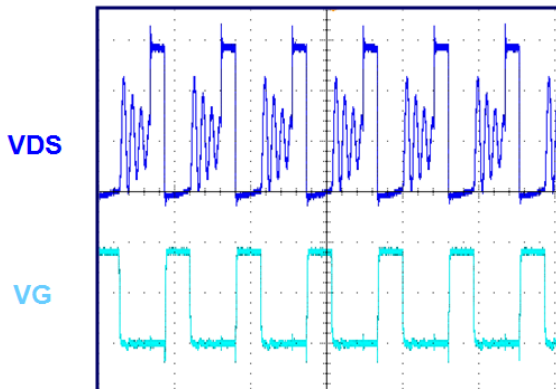


Figure 4: Preventing a False Turn-On (with Slew Rate Detection)

External Resistor on VD

Since over-voltage conditions may damage the device, there must be appropriate application designs to guarantee safe operation, especially on the high-voltage pin.

A common over-voltage condition is where the body diode of the SR MOSFET is turned on and the forward voltage drop may exceed the negative rating on VD. In this case, an external resistor should be placed between VD and the MOSFET drain. Generally, the resistance is recommended to be no less than 300Ω.

On the other hand, this resistor cannot be too large, since large resistor values slow down the slew rate on V_{DS} detection. Generally, it is not recommended to use any resistance value larger than 1kΩ but should be checked based on the slew rate for each practical case.

Typical System Implementations

Figure 5 shows the typical system implementation for the IC power supply derived from the output voltage, which is available in low-side rectification.

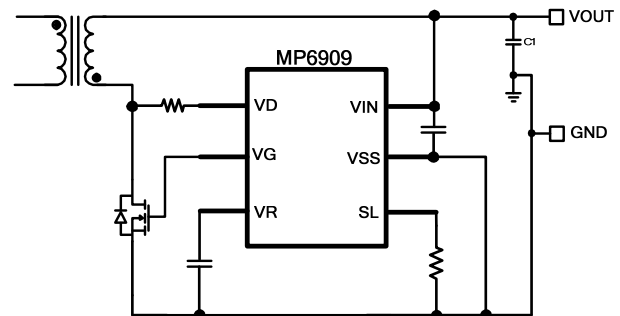


Figure 5: MP6909 in Low-Side Rectification

Figure 6 shows the circuit configuration for the auxiliary winding solution for the MP6909 used in high-side rectification.

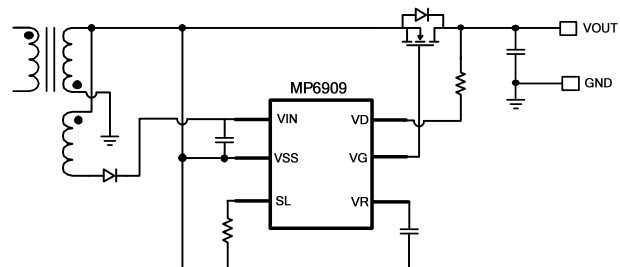


Figure 6: MP6909 in High-Side Rectification

SR MOSFET Selection

Power MOSFET selection is a tradeoff between the $R_{DS(ON)}$ and Q_G . To achieve higher efficiency, a MOSFET with a smaller $R_{DS(ON)}$ is preferred. Typically, Q_G is larger with a smaller $R_{DS(ON)}$, which makes the turn-on/turn-off speed lower and leads to larger power loss and driver loss. Because V_{DS} is adjusted at about -40mV during the driving period when the switching current is fairly small, a MOSFET with an $R_{DS(ON)}$ that is too low is not recommended because the gate driver is pulled low when $V_{DS} = -I_{SD} \times R_{DS(ON)}$ becomes larger than -40mV. The MOSFET's $R_{DS(ON)}$ does not contribute to the conduction loss. The conduction loss is $P_{CON} = -V_{DS} \times I_{SD} \approx I_{SD} \times 40mV$.

To achieve fairly high use of the MOSFET's $R_{DS(ON)}$, the MOSFET should be turned on completely for at least 50% of the SR conduction period. Calculate V_{DS} with Equation (2):

$$V_{DS} = -I_C \times R_{DS(ON)} = -I_{OUT} / D \times R_{DS(ON)} \leq -V_{fwd} \quad (2)$$

Where V_{DS} is drain-source voltage of the MOSFET, D is the duty cycle of the secondary side, I_{OUT} is output current, and V_{fwd} is the forward voltage threshold (~40mV).

Figure 7 shows the typical waveform of a flyback application. Assume it has a 50% duty cycle. The MOSFET's $R_{DS(ON)}$ is recommended to be no lower than $\sim 20/I_{OUT}$ (mΩ). For a 5A application, the $R_{DS(ON)}$ should be no lower than 4mΩ.

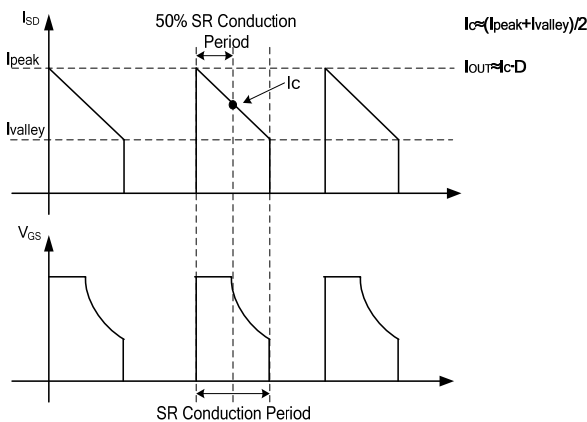


Figure 7: Synchronous Rectification Typical Waveforms in a Flyback Application

Slew Rate Set-Up

Select the slew rate set-up resistor carefully. Before placing a resistor on SL, measure the V_{DS} slew rate during normal turn-on and oscillation during DCM. Choose a resistor that can guarantee a normal SR driver turn-on. For example, if the V_{DS} slew rate is -1V/ns during the normal drop and 0.01V/ns in oscillation, a 0.1V/ns slew rate is a proper target to set up.

PCB Layout Guidelines

Efficient PCB layout is critical for stable operation. For best results, refer to Figure 8, Figure 9, Figure 10, and follow the guidelines below.

Sensing for VD/VSS

1. Make the sensing connection (VD/VSS) as close as possible to the MOSFET (drain/source).
2. Make the sensing loop as small as possible.
3. Keep the IC out of the power loop to prevent the sensing loop and power loop from interrupting each other (see Figure 8).

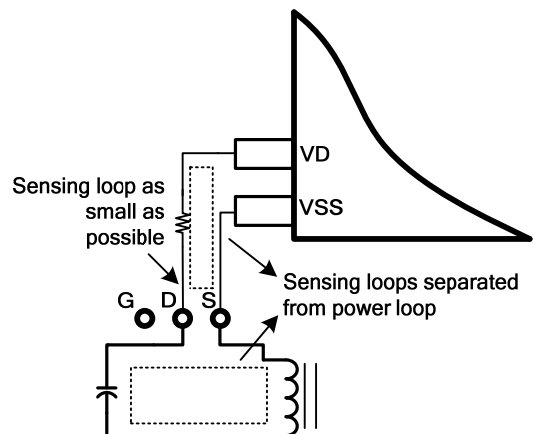


Figure 8: Voltage Sensing for VD/VSS

4. Place a decoupling ceramic capacitor from VR to PGND close to the IC for adequate filtering.

Gate Driver Loop

1. Make the gate driver loop as small as possible to minimize the parasitic inductance.
2. Keep the driver signal far away from the VD sensing trace on the layout.

Layout Example

Figure 9 shows a layout example of a single layer with a through-hole transformer and a TO220 package SR MOSFET. RSN and CSN are the RC snubber network for the SR MOSFET. The sensing loop (VD and VSS to the SR MOSFET) is minimized and kept separate from the power loop. The VR decoupling capacitor (C2) is placed beside VR.

Figure 10 shows another layout example of a single layer with a PowerPAK/SO8 package SR MOSFET, which also has a minimized sensing loop and power loop to prevent the loops from interfering with one another.

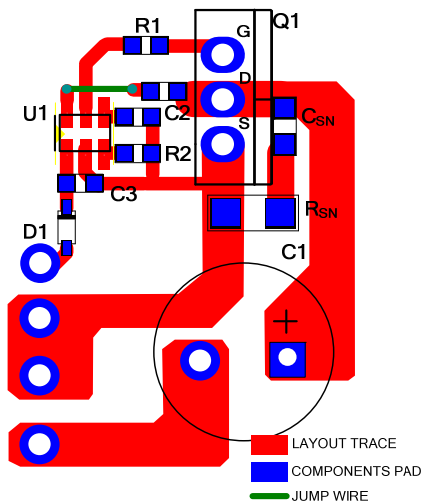


Figure 9: Layout Example with TO220 Package SR MOSFET

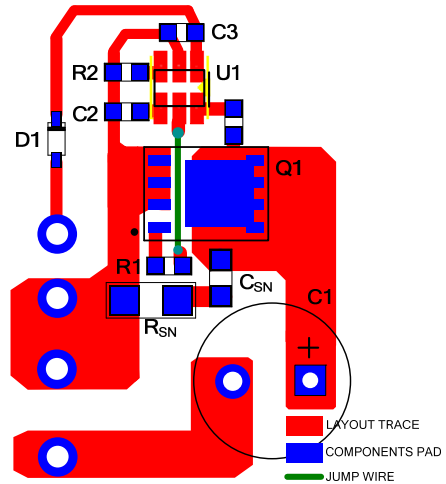
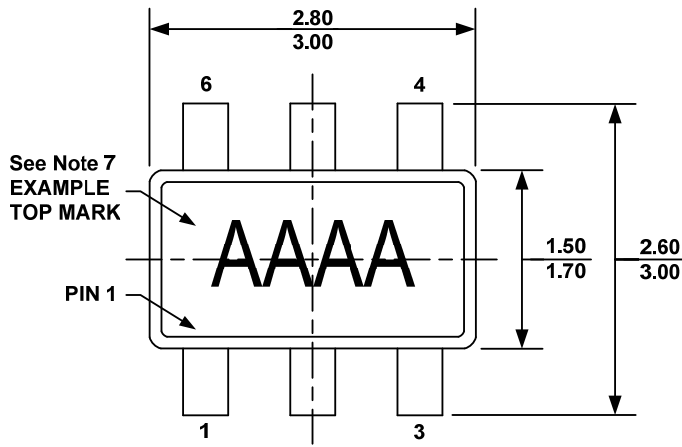


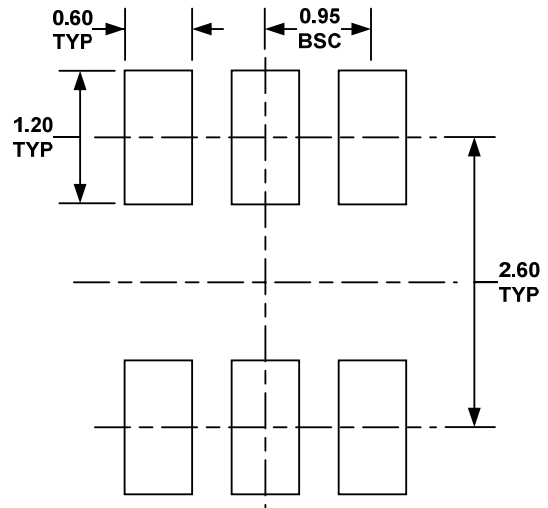
Figure 10: Layout Example with PowerPAK/SO8 SR MOSFET

PACKAGE INFORMATION

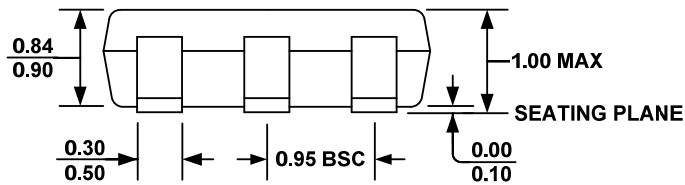
TSOT23-6



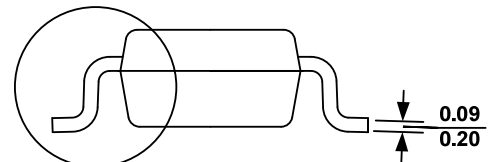
TOP VIEW



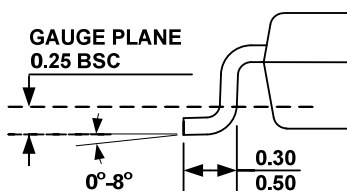
RECOMMENDED LAND PATTERN



FRONT VIEW



SEE DETAIL "A"



DETAIL “A”

NOTE:

- 1) ALL DIMENSIONS ARE IN MILLIMETERS.
- 2) PACKAGE LENGTH DOES NOT INCLUDE MOLD FLASH, PROTRUSION OR GATE BURR.
- 3) PACKAGE WIDTH DOES NOT INCLUDE INTERLEAD FLASH OR PROTRUSION.
- 4) LEAD COPLANARITY (BOTTOM OF LEADS AFTER FORMING) SHALL BE 0.10 MILLIMETERS MAX.
- 5) DRAWING CONFORMS TO JEDEC MO-193, VARIATION AB.
- 6) DRAWING IS NOT TO SCALE.
- 7) PIN 1 IS LOWER LEFT PIN WHEN READING TOP MARK FROM LEFT TO RIGHT, (SEE EXAMPLE TOP MARK)

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